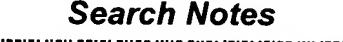


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/536,883 <b>Examiner</b> Karl J. Puttlitz	NAUD ET AL. <b>Art Unit</b> 1621

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Keyword search in file CAPLUS in STN; search in file	7/8/2007	KP
Inventor NPL search in file CAPLUS in STN; search in file	7/8/2007	KP
Inventor search in EDAN, PALM and EAST (USPGPUB and USPAT); EAST search in file	7/8/2007	KP
Review references cited in search report of counterpart PCT application	7/8/2007	KP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner